

<b>Notice of References Cited</b>	Application/Control No. 10/620,262	Applicant(s)/Patent Under Reexamination KEEFER ET AL.	
	Examiner Robert H. Spitzer	Art Unit 1724	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-3,201,921	08-1965	Heyes, Josef	95/92
	B	US-5,632,804	05-1997	Schartz, Fernande	95/101
	C	US-6,068,680	05-2000	Kulish et al.	95/98
	D	US-6,311,719	11-2001	Hill et al.	137/312
	E	US-6,457,485	10-2002	Hill et al.	137/240
	F	US-6,471,744	10-2002	Hill, Theodore B.	95/19
	G	US-6,488,747	12-2002	Keefer et al.	96/125
	H	US-6,514,318	02-2003	Keefer, Bowie G.	95/96
	I	US-6,514,319	02-2003	Keefer et al.	95/101
	J	US-6,712,087	03-2004	Hill et al.	137/240
	K	US-6,802,970	10-2004	Rochette, Filip	210/264
	L	US-2002/0056375	05-2002	Keefer, Bowie G.	96/125
	M	US-2002/0134246	09-2002	Babicki et al.	96/125

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.